



NPN MEDIUM POWER SILICON TRANSISTOR

Qualified per MIL-PRF-19500/393

DESCRIPTION

This family of high-frequency, epitaxial planar transistors feature low saturation voltage. These devices are also available in TO-5 and low profile U4 packages. Microsemi also offers numerous other transistor products to meet higher and lower power ratings with various switching speed requirements in both through-hole and surface-mount packages.

Important: For the latest information, visit our website http://www.microsemi.com.

FEATURES

- JEDEC registered 2N3418 through 2N3421 series.
- JAN, JANTX, and JANTXV qualifications are available per MIL-PRF-19500/393.
- RoHS compliant versions available (commercial grade only).
- $V_{CE(sat)} = 0.25 V @ Ic = 1 A.$
- Rise time t_r = 0.22 μs max @ I_C = 1.0 A, I_{B1} = 100 mA.
- Fall time t_f = 0.20 μs max @ I_C = 1.0 A, I_{B2} = -10 0 mA.

APPLICATIONS / BENEFITS

- General purpose transistors for medium power applications requiring high frequency switching and low package profile.
- Military and other high-reliability applications.

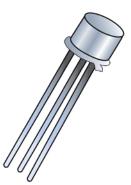
MAXIMUM RATINGS

Parameters / Test Conditions	Symbol	2N3418S 2N3420S	2N3419S 2N3421S	Unit
Collector-Emitter Voltage	V _{CEO}	60	80	V
Collector-Base Voltage	V _{CBO}	85	125	V
Emitter-Base Voltage	V _{EBO}	8		V
Collector Current tp <= 1 ms, duty cycle <= 50%	۱ _C		3 5	A
Total Power Dissipation@ $T_A = +25 \degree$ @ $T_C = +100$	°C ⁽¹⁾ P _D	1 5		W
Operating & Storage Junction Temperature	Range T _J , T _{stg}	-65 to	+200	°C

<u>Notes</u>: 1. Derate linearly 5.72 mW/°C for $T_A > +25$ °C.

2. Derate linearly 150 mW/°C for $T_C > +100$ °C.

<u>Qualified Levels</u>: JAN, JANTX and JANTXV



TO-39 (TO-205AD) Package

Also available in:

TO-5 package (leaded) 2N3418 - 2N3421

U4 package (surface mount) 2N3418U4 – 2N3421U4

MSC – Lawrence

6 Lake Street, Lawrence, MA 01841 Tel: 1-800-446-1158 or (978) 620-2600 Fax: (978) 689-0803

MSC – Ireland

Gort Road Business Park, Ennis, Co. Clare, Ireland Tel: +353 (0) 65 6840044 Fax: +353 (0) 65 6822298

Website:

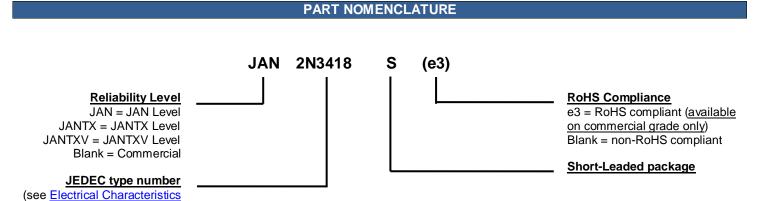
www.microsemi.com



MECHANICAL and PACKAGING

- CASE: Hermetically sealed, kovar base, nickel cap.
- MARKING: Part number, date code, manufacturer's ID.
- POLARITY: See <u>Package Dimensions</u> on last page.

table)



SYMBOLS & DEFINITIONS Symbol Definition Common-base open-circuit output capacitance. C_{obo} Collector cutoff current, base open. $\mathbf{I}_{\mathsf{CEO}}$ Collector cutoff current, circuit between base and emitter. **I**CEX I_{EBO} Emitter cutoff current, collector open. Common-emitter static forward current transfer ratio. h_{FE} TA Ambient temperature, free-air temperature. V_{CEO} Collector-emitter voltage, base open. Collector-emitter voltage, emitter open. V_{CBO} V_{EBO} Emitter-base voltage, collector open.



ELECTRICAL CHARACTERISTICS ($T_A = +25^{\circ}C$, unless otherwise noted)

OFF CHARACTERISTICS

Parameters / Test Conditions	Symbol	Min.	Max.	Unit	
Collector-Emitter Breakdown Cur	rent				
$I_{\rm C} = 50 {\rm mA}, I_{\rm B} = 0$	2N3418S, 2N3420S 2N3419S, 2N3421S	$V_{(BR)CEO}$	60 80		V
Collector-Emitter Cutoff Current					
V_{BE} = -0.5 V, V_{CE} = 80 V V _{BE} = -0.5 V, V_{CE} = 120 V	2N3418S, 2N3420S 2N3419S, 2N3421S	I _{CEX}		0.3 0.3	μA
Collector-Base Cutoff Current					
$V_{CE} = 45 \text{ V}, I_B = 0$ $V_{CE} = 60 \text{ V}, I_B = 0$	2N3418S, 2N3420S 2N3419S, 2N3421S	I _{CEO}		5.0 5.0	μA
Emitter-Base Cutoff Current $V_{EB} = 6.0 \text{ V}, I_C = 0$ $V_{EB} = 8.0 \text{ V}, I_C = 0$		I _{EBO}		0.5 10	μΑ

ON CHARACTERISTICS (1)

Parameters / Test Conditions	Symbol	Min.	Max.	Unit	
Forward-Current Transfer Ratio					
$I_{\rm C}$ = 100 mA, $V_{\rm CE}$ = 2.0 V	2N3418S, 2N3419S 2N3420S, 2N3421S		20 40		
I_{C} = 1.0 A, V_{CE} = 2.0 V	2N3418S, 2N3419S 2N3420S, 2N3421S	h _{FE}	20 40	60 120	
$I_{\rm C}$ = 2.0 A, $V_{\rm CE}$ = 2.0 V	2N3418S, 2N3419S 2N3420S, 2N3421S		15 30		
$I_{C} = 5.0 \text{ A}, V_{CE} = 5.0 \text{ V}$	2N3418S, 2N3419S 2N3420S, 2N3421S		10 15		
Collector-Emitter Saturation Volta					
I _C = 1.0 A, I _B = 0.1 A I _C = 2.0 A, I _B = 0.2 A		V _{CE(sat)}		0.25 0.5	V
Base-Emitter Saturation Voltage $I_C = 1.0 \text{ A}, I_B = 0.1 \text{ A}$ $I_C = 2.0 \text{ A}, I_B = 0.2 \text{ A}$		V _{BE(sat)}	0.6 0.7	1.2 1.4	V

DYNAMIC CHARACTERISTICS

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
Magnitude of Common Emitter Small-Signal Short Circuit Forward Current Transfer Ratio $I_{C} = 0.1 \text{ A}, V_{CE} = 10 \text{ V}, f = 20 \text{ MHz}$	h _{fe}	1.3	0.8	
Output Capacitance V_{CB} = 10 V, I_E = 0, 100 kHz \leq f \leq 1.0 MHz	C_{obo}		150	pF

NOTES: (1) Pulse Test: Pulse Width = 300 $\mu s,$ Duty Cycle \leq 2.0%.



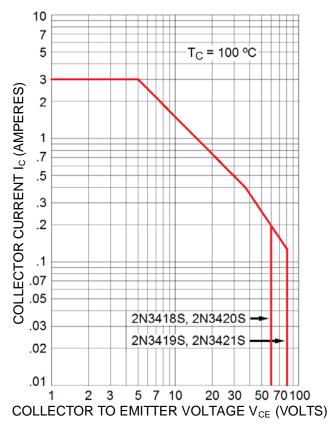
ELECTRICAL CHARACTERISTICS ($T_A = +25^{\circ}C$, unless otherwise noted) continued

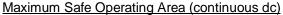
SWITCHING C	HARACTERISTICS
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Parameters / Test Conditions (for all symbols)		Symbol	Min.	Max.	Unit
Delay Time Rise Time	$V_{BE(off)} = -3.7 \text{ V},$ I _C = 1.0 A, I _{B1} = 100 mA	t _d t _r		0.08 0.22	μs
Storage Time Fall Time	$V_{BE(off)} = -3.7 V,$ I _C = 1.0 A, I _{B2} = -100 mA	t _s t _f		1.10 0.20	μs
Turn-Off Time	$V_{BE(off)}$ = -3.7 V, I _C = 1.0 A, I _{B2} = -100 mA, R _L = 20 Ω	t _{off}		1.20	μs

SAFE OPERATING AREA (See graph below and reference <u>MIL-STD-750</u>, method 3053)

DC Test	
T_{C} = +100 °C, 1 cycle, t \ge 1.0 s	
Test 1	
$V_{CE} = 5.0 \text{ V}, I_{C} = 3.0 \text{ A}$	
Test 2	
$V_{CE} = 37 \text{ V}, I_{C} = 0.4 \text{ A}$	
Test 3	
V _{CE} = 60 V, I _C = 0.185 A	2N3418S, 2N3420S
$V_{CE} = 80 \text{ V}, I_{C} = 0.12 \text{ A}$	2N3419S, 2N3421S
Clamped Switching	$T_A = +25 \text{ °C}, I_B = 0.5 \text{ A}, I_C = 3.0 \text{ A}$





T4-LDS-0192-1, Rev. 1 (111684)



GRAPHS

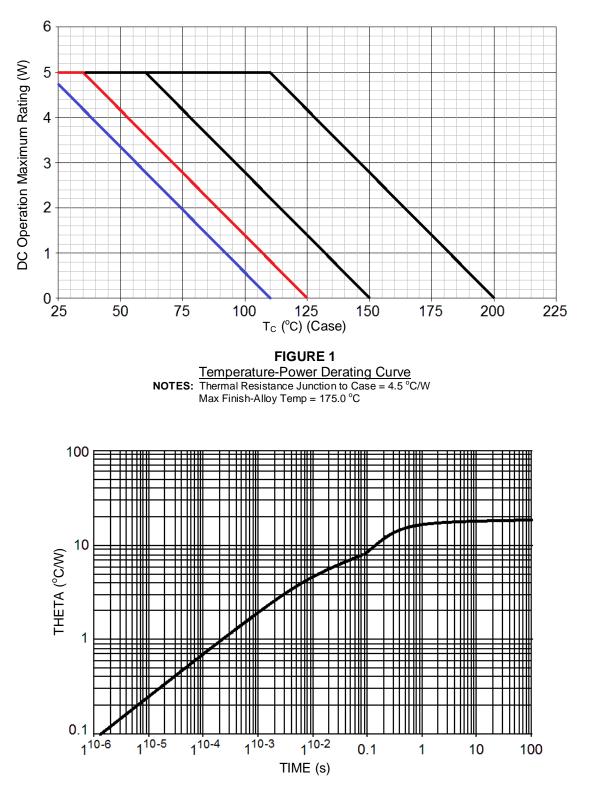
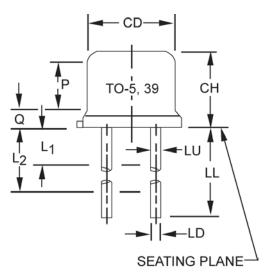


FIGURE 2 <u>Maximum Thermal Impedance</u> NOTE: $T_c = +25$ °C, Thermal Resistance $R_{\text{eJC}} = 4.5$ °C/W

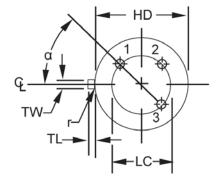
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PACKAGE DIMENSIONS



	Dimensions				
Symbol	Inches Millimeters		neters	Note	
	Min	Max	Min	Max	
CD	.305	.335	7.75	8.51	
СН	.240	.260	6.10	6.60	
HD	.335	.370	8.51	9.40	
LC	.200 TP		5.08	5.08 TP	
LD	.016	.021	0.41	0.53	
LL	.500	.750	12.7	19.05	7
LU		See notes	s 7, 13, 14	1	
L1		.050		1.27	7
L ₂	.250		6.35		7
Р	.100		2.54		5
Q		.040		1.02	4
TL	.029	.045	0.74	1.14	3, 10
TW	.028	.034	0.71	.86	9, 10
r		.010		0.25	11
α	45°	5° TP 45° TP		6	



- 1. Dimensions are in inches.
- 2. Millimeters are given for general information only.
- 3. Symbol TL is measured from HD maximum.
- 4. Details of outline in this zone are optional.
- 5. Symbol CD shall not vary more than .010 inch (0.25 mm) in zone P. This zone is controlled for automatic handling.
- 6. Leads at gauge plane .054 inch (1.37 mm) +.001 inch (0.03 mm) -.000 inch (0.00 mm) below seating plane shall be within .007 inch (0.18 mm) radius of TP relative to tab. Device may be measured by direct methods or by gauge.
- 7. Symbol LU applies between L1 and L2. Dimension LD applies between L2 and LL minimum. Diameter is uncontrolled in L1 and beyond LL minimum.
- 8. Lead number 3 is electrically connected to case.
- 9. Beyond r maximum, TW shall be held for a minimum length of .021 inch (0.53 mm).
- 10. Lead number 4 omitted on this variation.
- 11. Symbol r applied to both inside corners of tab.
- 12. For transistor types 2N3418S, 2N3419S, 2N3420S, 2N3421S, LL is .500 (12.70 mm) minimum and .750 (19.05 mm) maximum.
- 13. In accordance with ASME Y14.5M, diameters are equivalent to Φx symbology.
- 14. Lead 1 is emitter, lead 2 is base, and lead 3 is collector.